

Notice of References Cited	Application/Control No. 10/657,700	Applicant(s)/Patent Under Reexamination NIEMENMAA, JARKO	
	Examiner Charles Shedrick	Art Unit 2687	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,295,455	09-2001	Fischer et al.	455/456.2
	B	US-			
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